## Notice of References Cited Application/Control No. 10/721,350 Examiner Angela J. Martin Applicant(s)/Patent Under Reexamination MIYAKE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0220531 A1	11-2003	Cortright et al.	585/733
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N	JP 2002-015746	01-2002	Japan	Yonezu et al.	H01M 4/96		
	0	WO 02/13295 A1	02-2002	PCT	Nokuma et al.	H01M 4/86		
	Р							
	Q							
	R							
	s							
	Т							

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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